



ION BEAM ANALYSIS (IBA)

DESCRIPTION

Ion beam analysis (IBA) provides an excellent way to probe atomic compositions and concentrations in various materials in order to analytically analyze them. It can detect almost all types of atoms within the analyzed material and can even provide depth profiles. It is excellent in analyzing a wide range of samples, from unknown materials like asteroids, precious materials like diamonds to advanced materials like superlattices developed in nano-electronics.

APPLICATION DOMAINS

Material engineering, nano-electronics, ecology, medicine, forensics, rare materials.

MAIN ADVANTAGES

IBA techniques are very exact and highly reliable. Samples doesn't need any special treatment in advanced (chemical or physical), it is directly analyzed as it is, it is a fast analysis (minutes) and it's completely non-invasive. It is excellent for fragile or very expensive samples.

CONTACT

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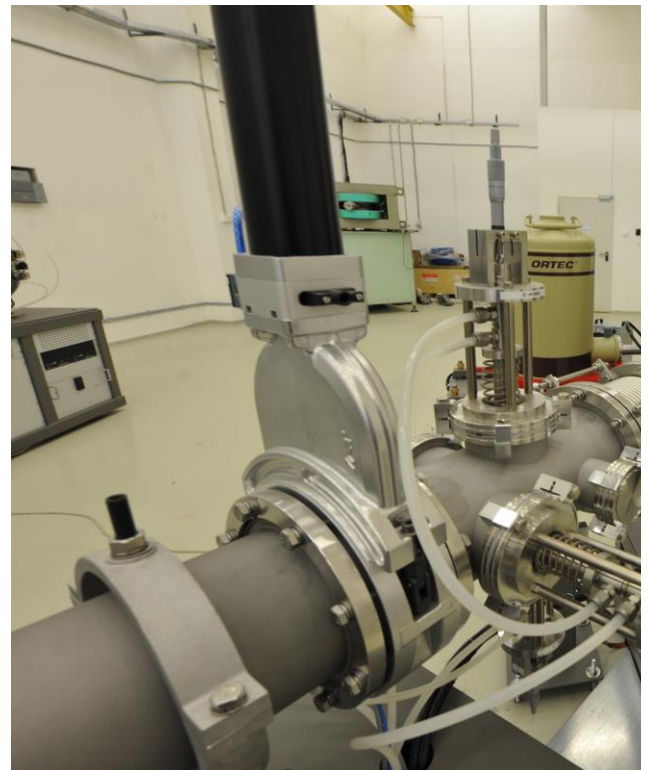
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POTENTIAL CUSTOMERS OR COMMERCIAL APPLICATIONS

Institutes of companies that develop and manufacture advanced materials or nano-electronics, chemical engineering, healthcare, ecological watchdogs, forensics inspectors, historians.

KEYWORDS

Ion beam analysis, IBA, RBS, RBS-C, PIXE, PIGE, NRA, thin films, atomic analysis, material analysis, forensics, medicine.